

Search Notes

Application/Control No.

10/775,284

Examiner

Patricia Leith

Applicant(s)/Patent under
Reexamination

LEE, YUAN Y.

Art Unit

1655

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST: JPO,EPO,DERWENT,USPATFULL,U SPGPUBS,OCRBACKFILE	6/11/2006	PL
ProQuest Direct (NPL internet site)	6/8/2006	PL
Inventor name search PALM/EAST	6/11/2006	PL